

<b>Notice of References Cited</b>	Application/Control No. 10/055,686	Applicant(s)/Patent Under Reexamination DUEN ET AL.	
	Examiner Kartic Padmanabhan	Art Unit 1641	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,150,103	11-2000	Ness et al.	435/6
*	B	US-5,798,161	08-1998	Kita et al.	428/64.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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